# Test Report



# Moon star Electrical switchgear manufacturing LLC

REPORT NUMBER: 4786583089.14.1

PROJECT NUMBER: 4786583089.14.1

UL – Underwriters
Laboratories Middle
East.

P.O.BOX: 345831

Dubai, United Arab Emirates(UAE)

TEL: +971 45585900

FAX: +971 45585036

#### **TEST DISCIPLINE: ELECTRICAL**

#### **General details**

	MOONSTAR ELECTRICA	I SWITCHGEAD		
	MOONSTAR ELECTRICAL SWITCHGEAR MANUFACTURING LLC			
Customer / Applicant				
	PO Box 48850, Dubai, UAE			
	MOONSTAR ELECTRICAL SWITCHGEAR MANUFACTURING LLC			
Manufacturer				
	PO Box 48850, Dubai, UAE			
Program	Others			
		Research Institute		
Test Lab Location	Others*	Prof.C.V Raman Road, Sadashivnagar P.B.No. 8066, Bangalore		
Item Under Test	2500A Internal Arc test Panel			
Model				
Number of Samples	1			
Sample Identification	SC15S1073 Refer Summary of Test results for multiple samples			
Manufacturer Serial Number	-			
(if any)				
Condition of IUT on receipt	Good			
Date of Receipt				
Applicable Standard	As per IEC TR 61641 Ed. 3.0			
Date of Testing (Start date)	26 August 2015	End Date	26 August 2015	
general ambient condition	Temperature in °C		10 to 40 °C	
general ambient condition	Relative humidity in %	< 70%		
Date of Reporting	31 January 2016			
Test In-charge	Mr. Santosh Tripathy			
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Santosh Tripathy

Sr.Project Engineer

Test witnessed by

Rachunall

Raghunath G

Engineering Leader

Approved by

Disclaimer

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\*\*The applicable standard ambient condition supersedes the lab general ambient conditions and are recorded in datasheets available in the lab.

#### General Remarks (If any)

#### **Description of Item under Test (IUT)**

#### Ratings assigned by the Applicant

1) Designation : 2500A Internal ARC test Panel

2) Panel Sr. No. :-

3) Rated operational voltage (U<sub>e</sub>) : 415Vac

4) Rated frequency : 50 Hz

5) Rated insulation voltage (U<sub>i</sub>) : 690V

6) Rated current of the ASSEMBLY (I<sub>nA</sub>) : 2500A

7) Permissible short circuit current under arcing condition (Ip arc): 50kA

8) Permissible arcing duration : 300ms

9) Bus bar details:

a. Main Bus bar : 2 x 100 x 10 sq.mm tinned copper per phase

b. Neutral Bus bar : 2 x 100 x 10 sq.mm tinned copper per phase

c. Earth Busbar : 1 x 100 x 10 sq.mm tinned copper per phase

10) Arcing class : B

11) Access : Restricted



## **Summary of Test Results**

Test No.	Test Parameter	Standard & Clause Number	Sample Identification	Result
1	Arc fault test	IEC TR 61641 cl No.8	SC15S1073	Р

P: Meets the requirements F: Does not meet the requirement NA: Not applicable



#### Test methodology adopted

As per standard

#### Test Detail: Arc fault test cl.8.0 of IEC TR 61641 Ed.no.3.0

The test was carried out on a new sample with the doors and covers are closed and correctly secured. The applied voltage to the test circuit is 105% of rated operational voltage. The test current is the average r.m.s values of a.c. component in all phases. The test sample is connected and supplied to the normal service arrangement. The PE & N conductor was connected to the neutral point of the test current source.

The arc was initiated at the joint of main bus bar by using bare copper wire of dia 1.5mm. For observing the thermal effects of gases indicators are used. The indicators were places vertically in a plane parallel to each other from floor upto the height of 2m and a distance of 300mm from the face. The indicators are uniformly distributed as a checkboard pattern.

#### PROSPECTIVE CURRENT & VOLTAGE FOR TEST

Supply Frequency: 50 Hz.

Oscillogram	Test voltage	Short circuit current values		Power factor	Remarks	
No.	Between	(kA)		(kA)		
	phases	Peak	Rms	Average	(Avg.)	
SC15469A.S01	■.	115.76	50.98 51.15 50.03	50.84	0.21	Calibration shot for current measurement
	417	-	-	-		Calibration shot for voltage measurement



The arc fault test was performed on the sample connected to the source as per test circuit diagram no. a. The arc was initiated by using a bare copper wire of 1.5 sq.mm connected at joint of the main bus bar,

Condition of the equipment under test: New, without any current limiting device

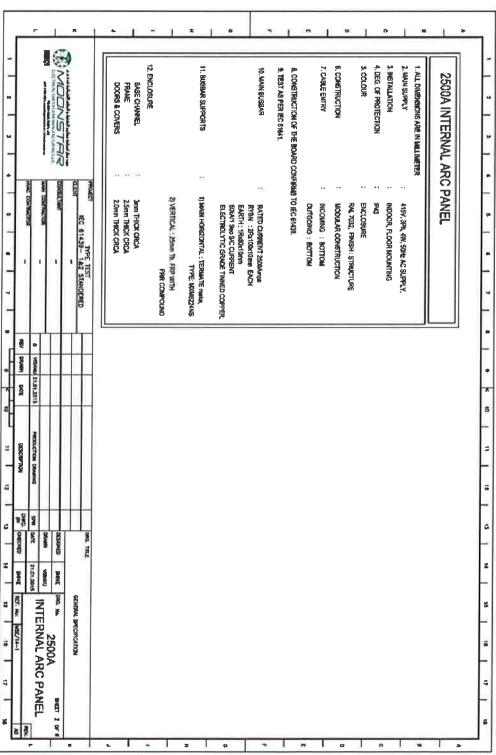
Oscillogram No.	Peak Current kA	RMS current (kA)	Arcing duration (msecs.)	Total I <sup>2</sup> t (A <sup>2</sup> S X 10 <sup>6</sup> )	Remarks
SC15469A.S02	65.57	28.11 26.51 21.31	340	69.42 39.63 34.82	Arcing continued for 340ms

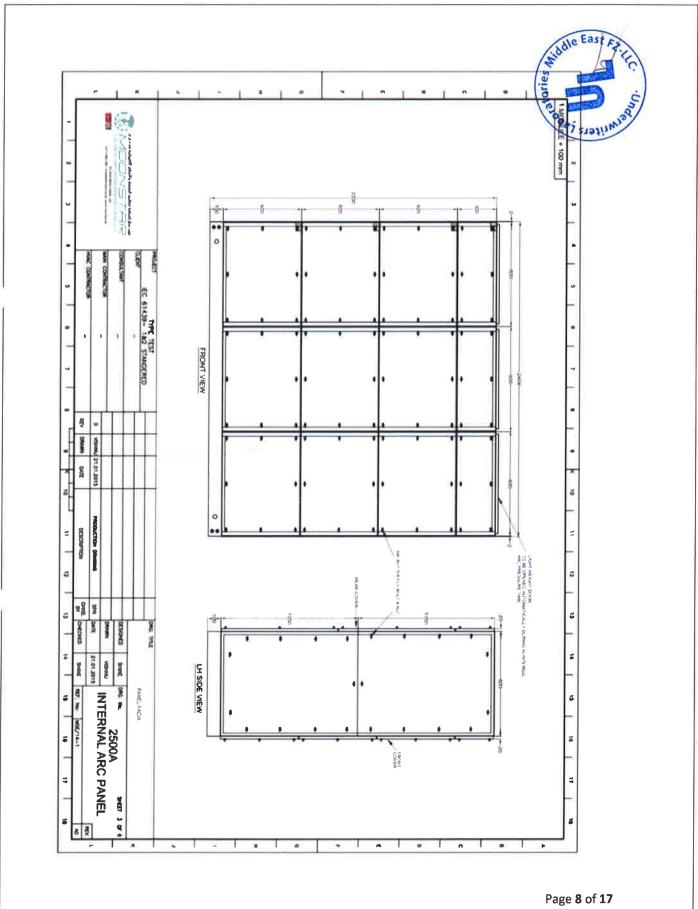
Observation after test: - a) Doors were not opened.

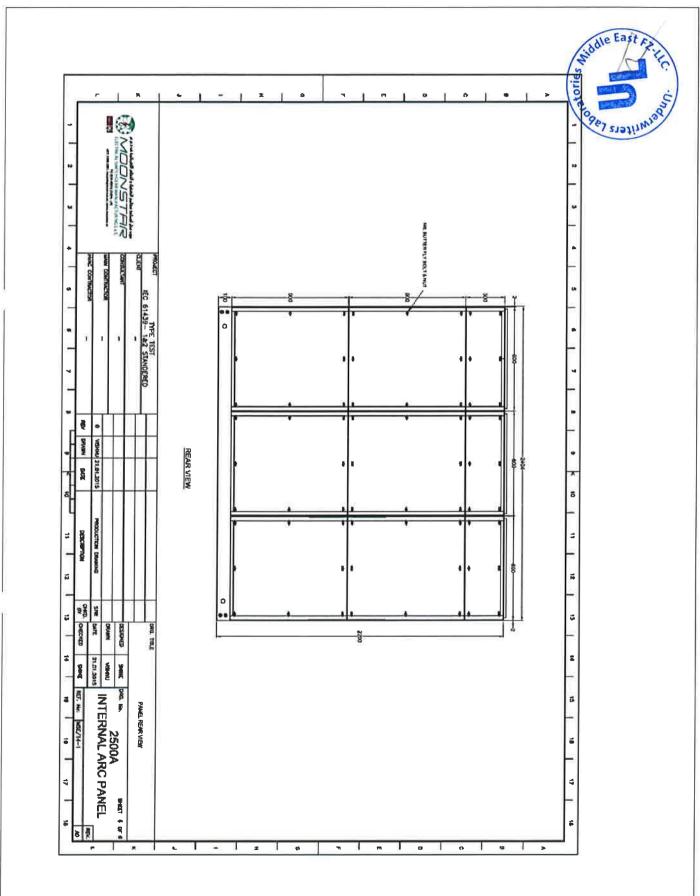
- b) Busbar connections were not loosened.
- c) No deformation in busbars observed
- d) Indicators were not ignited.
- e) Busbar supports were intact.
- f) No holes were observed in the other parts
- g) The equipotential bonding arrangement for accessible parts of the enclosure was still effective.
- h) After clearance of the fault the unit withstood dielectric verification test for at 1.5Ue for 60 sec.

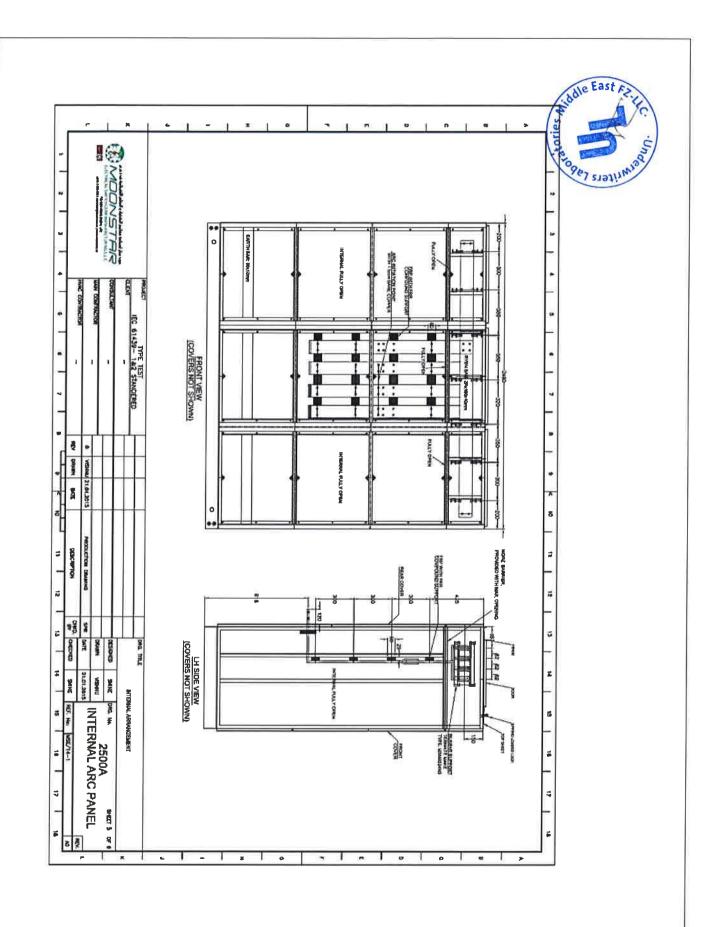


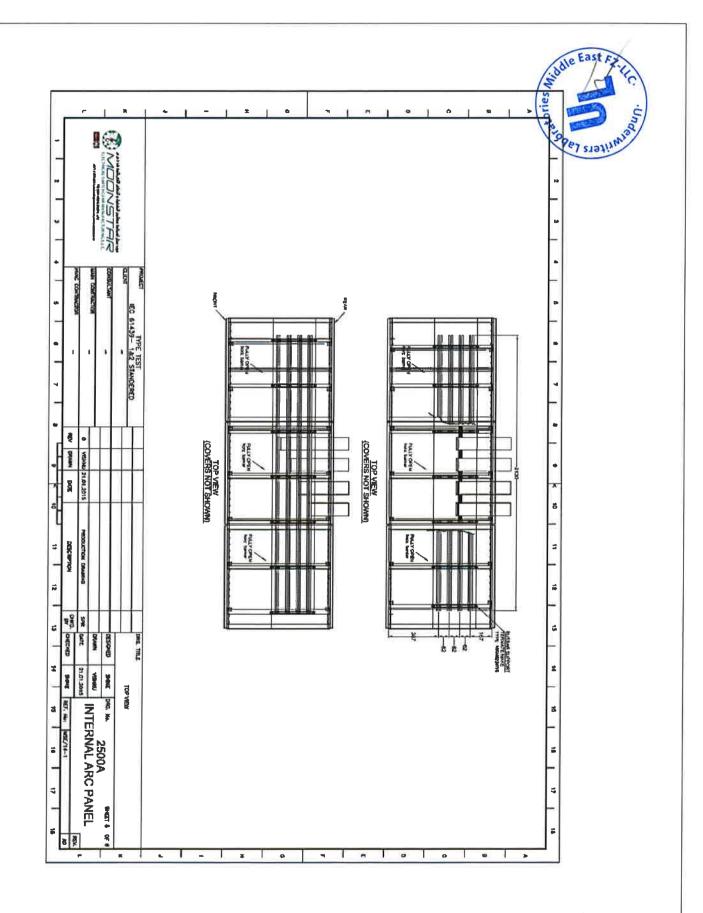
#### **Drawings:**



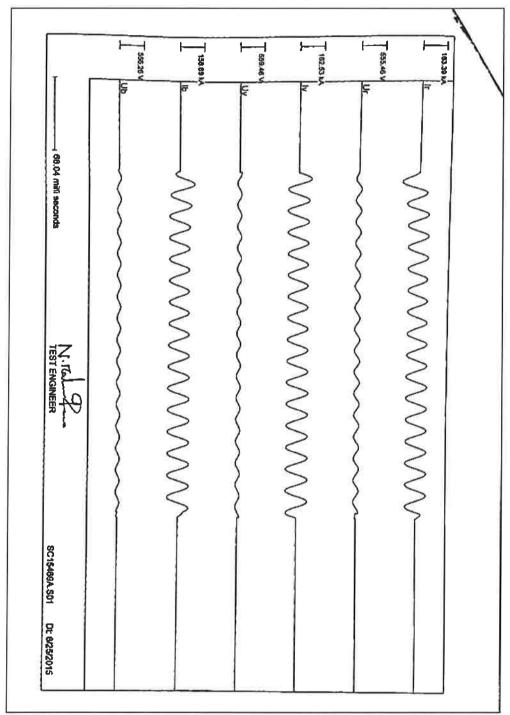




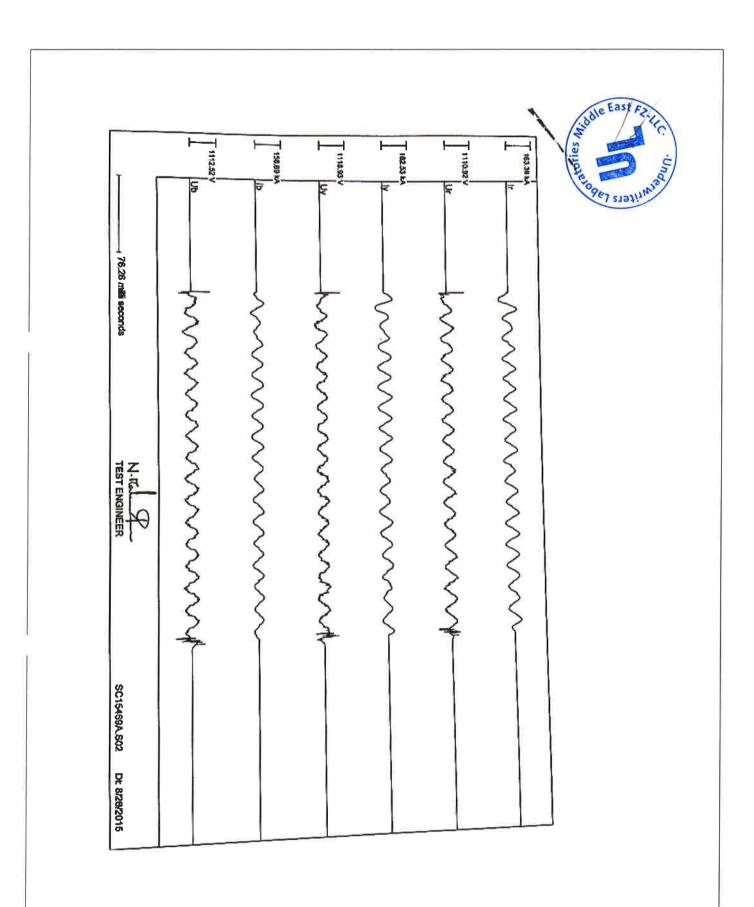




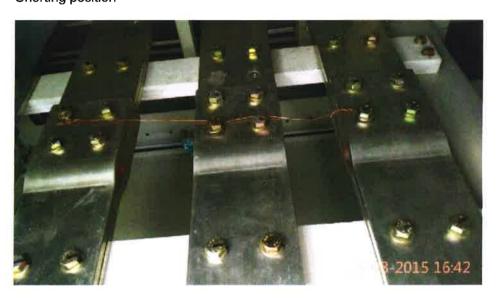
## Oscillograms







# Photographs Shorting position



## Indicators arrangement



# Indicators arrangement







Flap opened during test



*****End of Report*****
Page <b>17</b> of <b>17</b>